

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/725,171	HAUN, MICHAEL J.	
Examiner Russell J. Kemmerle III		Art Unit 1731	Page 1 of 1	

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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